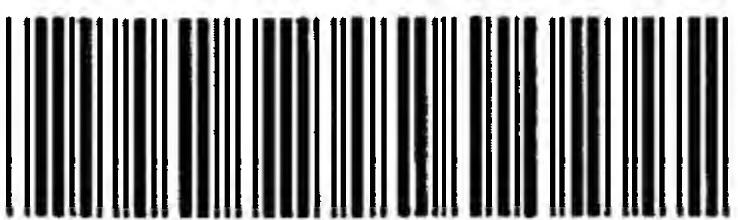


Search Notes**Application/Control No.**

10/710,421

Examiner

Joseph Nguyen

Applicant(s)/Patent under Reexamination

SHEI ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	79, 99	4/3/2006	JN
257	90, 778	4/3/2006	JN
257	355	4/3/2006	JN
257	e33.052	4/3/2006	JN
257	e33.056	4/3/2006	JN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search history in EAST	4/3/2006	JN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	79, 99	4/3/06	JN
257	90, 778	4/3/06	JN
257	355	4/3/06	JN
257/E33.052			
E33.056			